PCE 1-5133 #10/5-10-00

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:

Takaki YOSHIDA et al.

Group Art Unit: 2133

Serial No.: 09/697,305

Examiner: Joseph D. Torres

Filed: October 27, 2000

For: FAULT DETECTING METHOD AND LAYOUT METHOD

FOR SEMICONDUCTOR INTEGRATED CIRCUIT

PETITION FOR EXTENSION OF TIME AND TRANSMITTAL OF FEE UNDER 37 C.F.R. §1.17 ECEIVED

MAY 0 5 2004

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Technology Center 2100

Sir:

Action in the above-identified application. The shortened statutory period having expired April 2, 2004, it is hereby requested that the period for response be extended for one (1) month. There is also attached our Check No. 17604 in the amount of \$110.00 in payment for:

Extension fee for response within second month pursuant to \$1.136(a) (\$420.00) [\$210.00].

Serial No. 09/697,305

Extension fee for response within third month pursuant to §1.136(a) (\$950.00) [\$475.00].

1.

The Commissioner is hereby authorized to charge any additional fee (or credit any overpayment) associated with this communication to Deposit Account No. 16-0331. A duplicate copy of this letter is enclosed.

Respectfully submitted,

PARKHURST & WENDEL, L.L.P.

April 30, 2004

Date

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Roger W. Parkhurst

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RWP: RWP/mhs

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PLEASE ACCEPT THIS AS
AUTHORIZATION TO DEBIT
OR CREDIT FEES TO
PARKHURST & WENDEL